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04 AUG 2000

FORM PTO-1449
(REV. 7-80)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO. :

BIERBAUMER ET AL-2 PCT

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
MRL	AA	3,142,759	07/28/64	JEFFERSON ET AL	250	106	_____
MRL	AB	3,564,241	02/16/71	LUDWIG	250	52	_____
MRL	AC	4,446,374	05/10/84	IVANOV ET AL	250	492.3	_____
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	AE						
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	AI						

FOREIGN PATENT DOCUMENTS

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MRL	AL	WO 94/22162	09/94	INTERNATIONAL	_____	_____	✓	
MRL	AM	EP 0 731 626	09/96	EUROPEAN	_____	_____	✓	
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

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Mayer R. Schubert

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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Mongul Chulaj

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MRL	AR	—	Burns P. et al, "The measurement, control, and validation of critical parameters in an electron beam sterilization facility", Nuclear Instruments & Methods in Physics Research, Section-B, Beam Interactions with Materials and Atoms, vol. 113, no. 1, 1 June 1996, pages 96-98, XP004007773
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Morgan R. Chubij

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